L Number	Hits	Search Text	DB	Time stamp
1	756	photoresist$4 same (bubble or shell)	USPAT; US-PGPUB	2003/07/25 10:23
2	115	(photoresist$4 same (bubble or shell)) and electron and microscop$2	USPAT; US-PGPUB	2003/07/25 10:23
3	38	((photoresist$4 same (bubble or shell)) and electron and microscop$2) and (flood$3 or inspect$4)	USPAT; US-PGPUB	2003/07/25 10:35
4	2104	250/310	USPAT; US-PGPUB	2003/07/25 10:35
5	1646	250/311	USPAT; US-PGPUB	2003/07/25 10:35
6	2446	250/306	USPAT; US-PGPUB	2003/07/25 10:35
7	2044	250/307	USPAT; US-PGPUB	2003/07/25 10:36
8	393	(250/310 or 250/311 or 250/306 or 250/307) and photoresist$4	USPAT; US-PGPUB	2003/07/25 11:17
9	338	((250/310 or 250/311 or 250/306 or 250/307) and photoresist$4) and layer	USPAT; US-PGPUB	2003/07/25 11:17
10	82	(((250/310 or 250/311 or 250/306 or 250/307) and photoresist$4) and layer) and electron and inspect$4	USPAT; US-PGPUB	2003/07/25 11:17
11	79	((((250/310 or 250/311 or 250/306 or 250/307) and photoresist$4) and layer) and electron and inspect$4) and microscop$2	USPAT; US-PGPUB	2003/07/25 11:18
12	11	(US-6143666-$ or US-5783366-$ or US-6444381-$ or US-5510216-$ or US-6420702-$ or US-6589709-$ or US-6358670-$ or US-5928821-$ or US-5242864-$ or US-6121130-$ or US-5747803-$).did.	USPAT	2003/07/25 11:15
13	148	430/16	USPAT	2003/07/25 11:15
14	512	430/23	USPAT	2003/07/25 11:15
15	1939	430/30	USPAT	2003/07/25 11:15
16	1898	430/296	USPAT	2003/07/25 11:16
17	3011	430/311	USPAT	2003/07/25 11:16
18	984	438/623	USPAT	2003/07/25 11:16
19	637	438/701	USPAT	2003/07/25 11:16
20	823	438/725	USPAT	2003/07/25 11:16
21	4652	(430/16 or 430/23 or 430/30 or 430/296 or 430/311 or 438/623 or 438/701 or 438/725) and photoresist$4	USPAT; US-PGPUB	2003/07/25 11:17
22	4311	((430/16 or 430/23 or 430/30 or 430/296 or 430/311 or 438/623 or 438/701 or 438/725) and photoresist$4) and layer	USPAT; US-PGPUB	2003/07/25 11:17
23	304	(((430/16 or 430/23 or 430/30 or 430/296 or 430/311 or 438/623 or 438/701 or 438/725) and photoresist$4) and layer) and electron and inspect$4	USPAT; US-PGPUB	2003/07/25 11:18
24	149	((((430/16 or 430/23 or 430/30 or 430/296 or 430/311 or 438/623 or 438/701 or 438/725) and photoresist$4) and layer) and electron and inspect$4) and microscop$2	USPAT; US-PGPUB	2003/07/25 11:18
25	13	(((((430/16 or 430/23 or 430/30 or 430/296 or 430/311 or 438/623 or 438/701 or 438/725) and photoresist$4) and layer) and electron and inspect$4) and microscop$2) and flood$3	USPAT; US-PGPUB	2003/07/25 11:18

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-	5579	inspect$4 and (Electron adj microscop$4)	USPAT; US-PGPUB	2003/07/23 17:30
-	5944	inspect$4 and (Electron adj microscop$4)	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 13:19
-	4132	(inspect$4 and (Electron adj microscop$4)) and layer$3	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 13:20
-	427	((inspect$4 and (Electron adj microscop$4)) and layer$3) and untreat$3 and treat$4	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 15:32
-	0	"09820143"	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 13:26
-	52	(((inspect$4 and (Electron adj microscop$4)) and layer$3) and untreat$3 and treat$4) and photoresist$3	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 15:42
-	728	((inspect$4 and (Electron adj microscop$4)) and layer$3) and ((untreat$3 and treat$4) or (expos$3 and unexpos$3) or (radiat$3 and unradiat$3))	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 15:34
-	579	((inspect$4 and (Electron adj microscop$4)) and layer$3) and ((untreat$3 same treat$4) or (expos$3 same unexpos$3) or (radiat$3 same unradiat$3))	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 15:34
-	159	(((inspect$4 and (Electron adj microscop$4)) and layer$3) and ((untreat$3 same treat$4) or (expos$3 same unexpos$3) or (radiat$3 same unradiat$3))) and photoresist$3	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 15:58
	26	((((inspect$4 and (Electron adj microscop$4)) and layer$3) and ((untreat$3 same treat$4) or (expos$3 same unexpos$3) or (radiat$3 same unradiat$3))) and photoresist$3) and flood$3	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 08:59
-	18	okoroanyanwu.in.	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 17:29
-	160	singh-bhanwar.in.	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 17:29
-	0	acheta-alden.in.	USPAT; US-PGPUB; EPO; DERWENT	2003/07/23 17:29
-	35	(okoroanyanwu.in. or singh-bhanwar.in.) and (Electron adj microscop$4)	USPAT; US-PGPUB	2003/07/23 17:30
	1	((okoroanyanwu.in. or singh-bhanwar.in.) and (Electron adj microscop$4)) and untreat$3	USPAT; US-PGPUB	2003/07/23 17:30
-	676	layer$3 and flood$3 and photoresist$3 and (integrat$3 adj circuit$3)	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 10:38
-	511	(layer$3 and flood$3 and photoresist$3 and (integrat$3 adj circuit$3)) and region	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 10:38
-	442	((layer$3 and flood$3 and photoresist$3 and (integrat$3 adj circuit$3)) and region) and reduc$5	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 10:40

–	20	(((layer$3 and flood$3 and photoresist$3 and (integrat$3 adj circuit$3)) and region) and reduc$5) and shell	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 11:10
–	88	(((layer$3 and flood$3 and photoresist$3 and (integrat$3 adj circuit$3)) and region) and reduc$5) and inspec$5	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 11:16
–	40	((((layer$3 and flood$3 and photoresist$3 and (integrat$3 adj circuit$3)) and region) and reduc$5) and inspec$5) and enclos$3	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 12:28
–	266052	inspect$4 amd electron and (electron adj microscop$2) and (integrated adj circuit)	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 12:38
–	10485	(inspect$4 amd electron and (electron adj microscop$2) and (integrated adj circuit)) and layer and surface and transform$	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 12:44
–	624	((inspect$4 amd electron and (electron adj microscop$2) and (integrated adj circuit)) and layer and surface and transform$) and ((enclos$3 or encapsulat$3) near4 (surface or layer))	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 12:45
–	45	(((inspect$4 amd electron and (electron adj microscop$2) and (integrated adj circuit)) and layer and surface and transform$) and ((enclos$3 or encapsulat$3) near4 (surface or layer))) and photoresist	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 12:45
–	52	(((inspect$4 amd electron and (electron adj microscop$2) and (integrated adj circuit)) and layer and surface and transform$) and ((enclos$3 or encapsulat$3) near4 (surface or layer))) and photoresist$3	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 15:01
–	527	(shell or (cross adj link$4)) and (barrier or trap$4) and layer and outgas$4	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 15:03
–	47	((shell or (cross adj link$4)) and (barrier or trap$4) and layer and outgas$4) and photoresist$4	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 15:07
–	2	5330881.pn.	USPAT; US-PGPUB; EPO; DERWENT	2003/07/24 15:07
–	811	inspect$3 and (integrat$3 adj circuit) and (electron adj microscop$2) and electron and beam	USPAT; US-PGPUB	2003/07/25 08:41
–	181	(inspect$3 and (integrat$3 adj circuit) and (electron adj microscop$2) and electron and beam) and ((treat$4 or transform$5) same surface)	USPAT; US-PGPUB	2003/07/25 08:42
–	12	(inspect$3 and (integrat$3 adj circuit) and (electron adj microscop$2) and electron and beam) and ((treat$4 or transform$5) same surface same ("SEM" or microscop$2) same inspect$4)	USPAT; US-PGPUB	2003/07/25 08:43
–	12	((inspect$3 and (integrat$3 adj circuit) and (electron adj microscop$2) and electron and beam) and ((treat$4 or transform$5) same surface)) and ((treat$4 or transform$5) same surface same ("SEM" or microscop$2) same inspect$4)	USPAT; US-PGPUB	2003/07/25 10:22

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